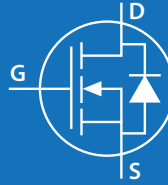


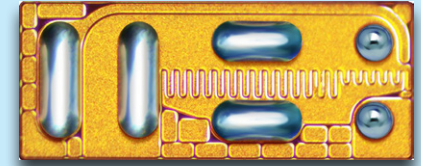
EPC8002 – Enhancement Mode Power Transistor

 V_{DS} , 65 V $R_{DS(on)}$, 480 mΩ I_D , 2 A

Revised July 7, 2023

Gallium Nitride's exceptionally high electron mobility and low temperature coefficient allows very low $R_{DS(on)}$, while its lateral device structure and majority carrier diode provide exceptionally low Q_G and zero Q_{RR} . The end result is a device that can handle tasks where very high switching frequency, and low on-time are beneficial as well as those where on-state losses dominate.

Questions:
Ask a GaN
Expert



Die size: 2.1 x 0.85 mm

EPC8002 eGaN FETs are supplied only in passivated die form with solder bars.

Applications

- Ultra high speed DC-DC conversion
- RF envelope tracking
- Wireless power transfer
- Game console and industrial movement sensing (lidar)

Benefits

- Ultra high efficiency
- Ultra low $R_{DS(on)}$
- Ultra low Q_G
- Ultra small footprint

Scan QR code or click link below for more information including reliability reports, device models, demo boards!



<https://l.ead.me/EPC8002>

Maximum Ratings			
PARAMETER		VALUE	UNIT
V_{DS}	Drain-to-Source Voltage (Continuous)	65	V
	Drain-to-Source Voltage (up to 10,000 5 ms pulses at 150°C)	78	
I_D	Continuous ($T_A = 25^\circ\text{C}$, $R_{\theta JA} = 36^\circ\text{C/W}$)	2	A
	Pulsed (25°C , $T_{PULSE} = 300 \mu\text{s}$)	2	
V_{GS}	Gate-to-Source Voltage	6	V
	Gate-to-Source Voltage	-4	
T_J	Operating Temperature	-40 to 150	°C
T_{STG}	Storage Temperature	-40 to 150	

Thermal Characteristics			
PARAMETER		TYP	UNIT
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	8.2	°C/W
$R_{\theta JB}$	Thermal Resistance, Junction-to-Board	16	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1)	82	

Note 1: $R_{\theta JA}$ is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board. See https://epc-co.com/epc/documents/product-training/Appnote_Thermal_Performance_of_eGaN_FETs.pdf for details

Static Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise stated)						
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
BV_{DSS}	Drain-to-Source Voltage	$V_{GS} = 0 \text{ V}$, $I_D = 125 \mu\text{A}$	65			V
I_{DSS}	Drain-Source Leakage	$V_{GS} = 0 \text{ V}$, $V_{DS} = 52 \text{ V}$		20	100	μA
I_{GSS}	Gate-to-Source Forward Leakage	$V_{GS} = 5 \text{ V}$		0.1	1	mA
	Gate-to-Source Reverse Leakage	$V_{GS} = -4 \text{ V}$		20	100	μA
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 0.1 \text{ mA}$	0.8	1.4	2.5	V
$R_{DS(on)}$	Drain-Source On Resistance	$V_{GS} = 5 \text{ V}$, $I_D = 0.5 \text{ A}$		380	480	mΩ
V_{SD}	Source-Drain Forward Voltage [#]	$V_{GS} = 0 \text{ V}$, $I_S = 0.4 \text{ A}$		2.6		V

[#] Defined by design. Not subject to production test.

All measurements were done with substrate connected to source.

Specifications are with substrate connected to source where applicable.

Dynamic Characteristics# (T_J= 25°C unless otherwise stated)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
C _{ISS}	Input Capacitance	V _{GS} = 0 V, V _{DS} = 32.5 V		20	24	pF
C _{RSS}	Reverse Transfer Capacitance			0.12	0.18	
C _{OSS}	Output Capacitance			6.7	10	
C _{OSS(ER)}	Effective Output Capacitance, Energy Related (Note 2)	V _{GS} = 0 V, V _{DS} = 0 to 32.5 V		8.9		pF
C _{OSS(TR)}	Effective Output Capacitance, Time Related (Note 3)			10		
R _G	Gate Resistance			0.3		Ω
Q _G	Total Gate Charge	V _{GS} = 5 V, V _{DS} = 32.5 V, I _D = 0.5 A		133	167	pC
Q _{GS}	Gate-to-Source Charge	V _{DS} = 32.5 V, I _D = 0.5 A		57		
Q _{GD}	Gate-to-Drain Charge			15	26	
Q _{G(TH)}	Gate Charge at Threshold			46		
Q _{OSS}	Output Charge	V _{GS} = 0 V, V _{DS} = 32.5 V		334	500	
Q _{RR}	Source-Drain Recovery Charge			0		

Defined by design. Not subject to production test.

All measurements were done with substrate connected to source.

Note 2: C_{OSS(ER)} is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.

Note 3: C_{OSS(TR)} is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.

Figure 1: Typical Output Characteristics at 25°C

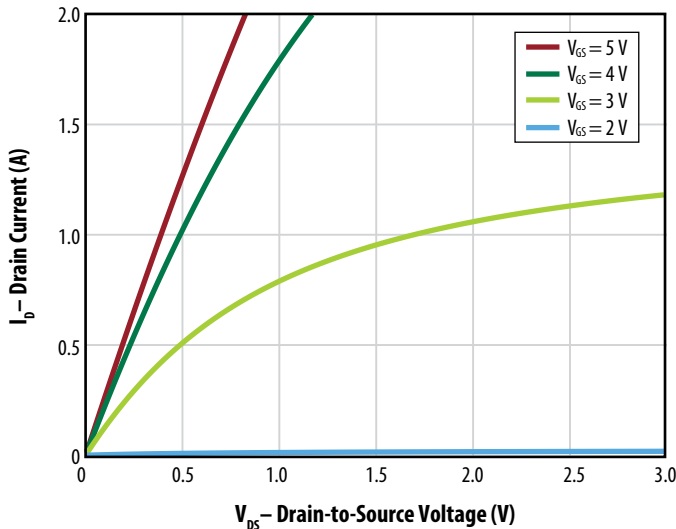


Figure 2: Typical Transfer Characteristics

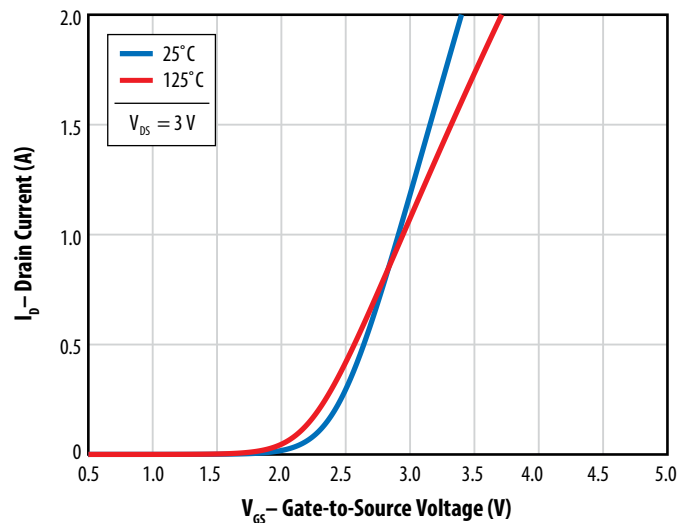


Figure 3: Typical R_{DS(on)} vs V_{GS} for Various Drain Currents

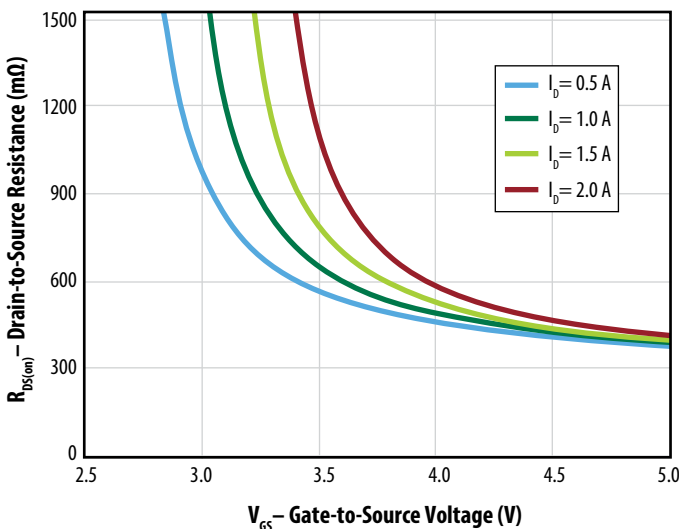


Figure 4: Typical R_{DS(on)} vs V_{GS} for Various Temperatures

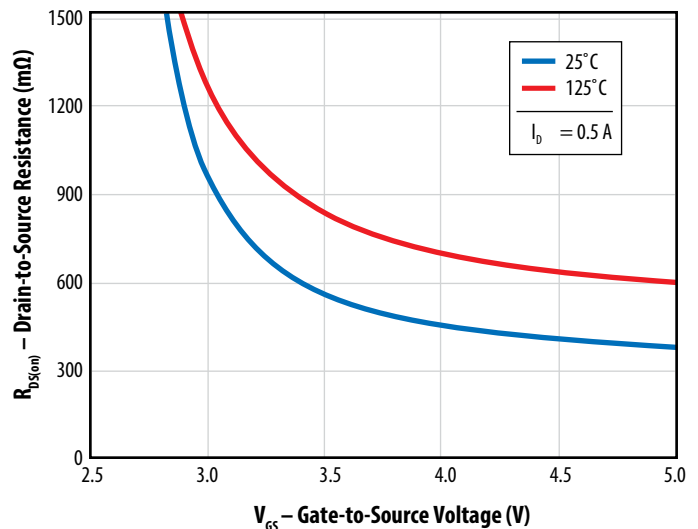


Figure 5: Typical Capacitance (Linear Scale)

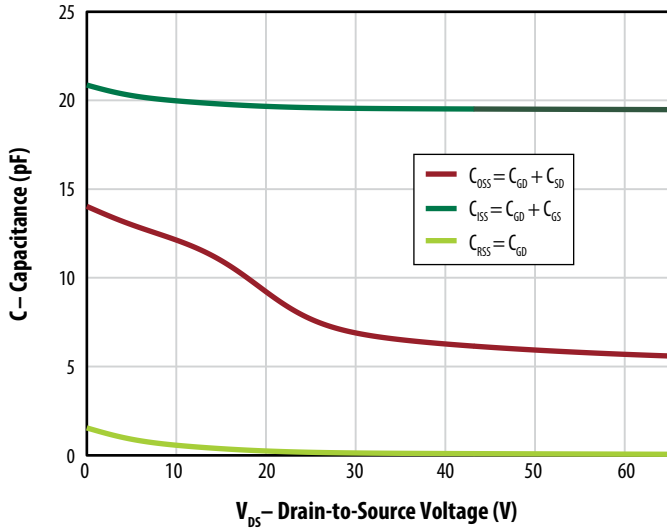


Figure 5A: Typical Capacitance (Log Scale)

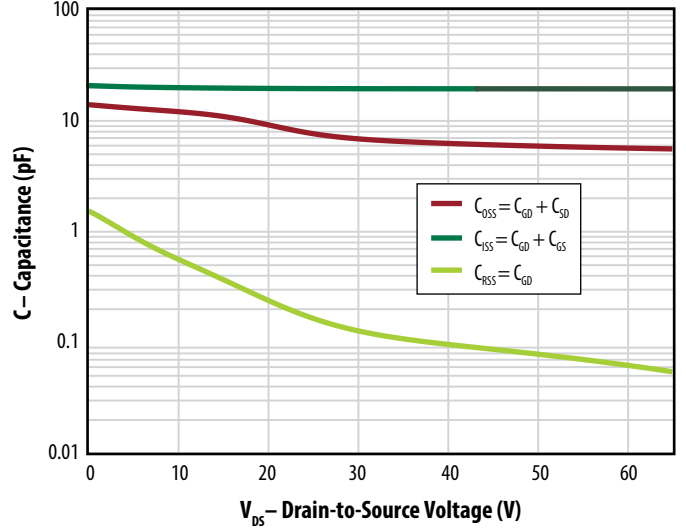


Figure 6: Typical Gate Charge

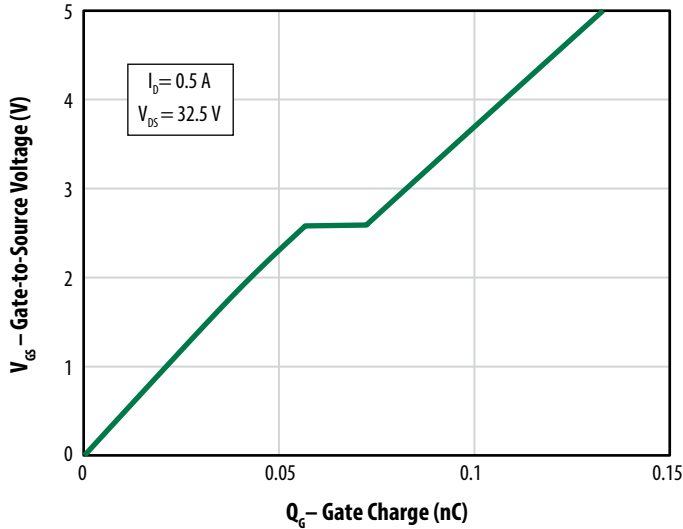
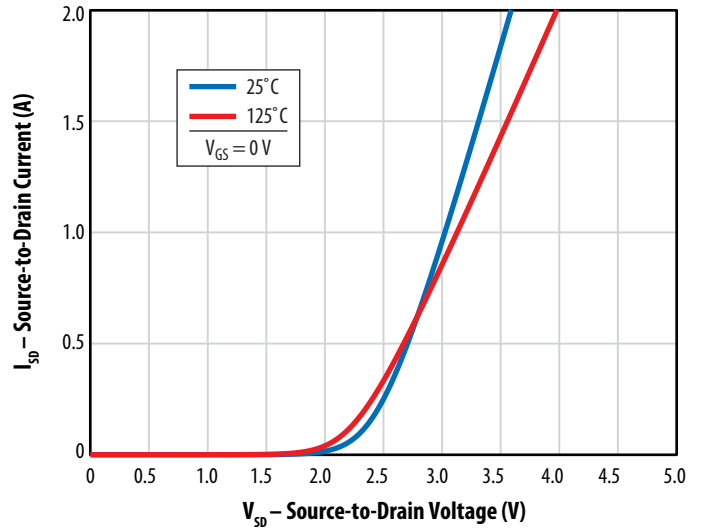


Figure 7: Typical Reverse Drain-Source Characteristics



Note: Negative gate drive voltage increases the reverse drain-source voltage. EPC recommends 0 V for OFF.

Figure 8: Typical Normalized On-State Resistance vs Temp.

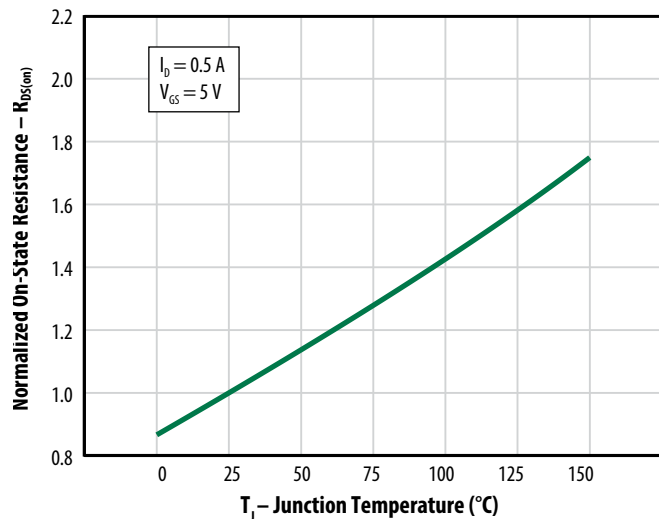


Figure 9: Typical Normalized Threshold Voltage vs Temp.

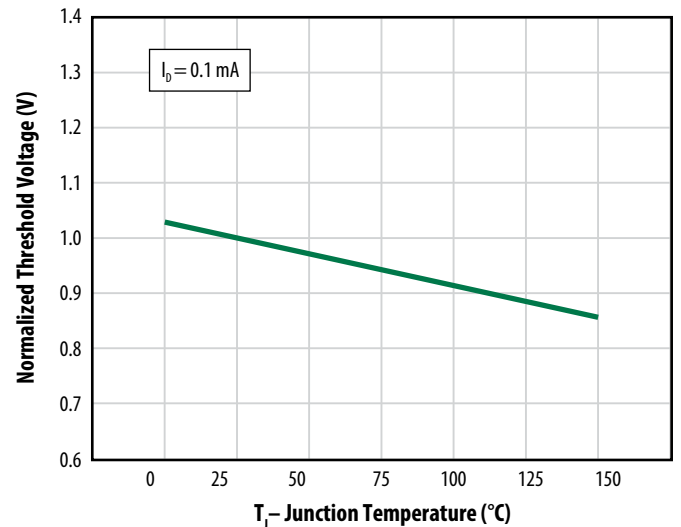


Figure 10: Typical Gate Leakage Current

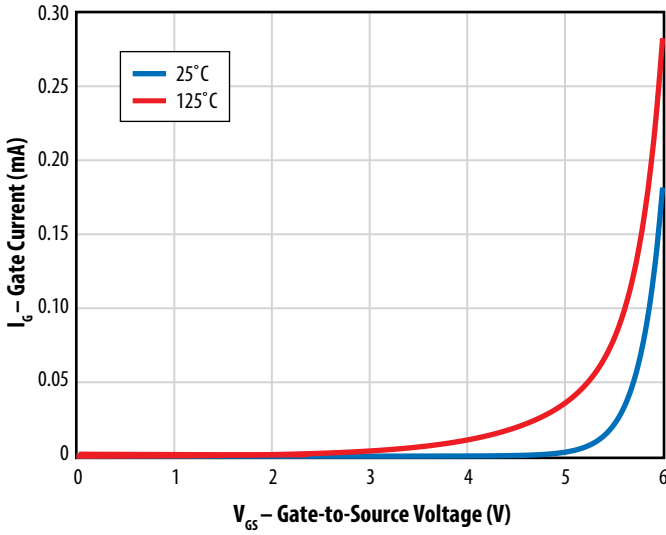


Figure 11: Smith Chart

S-Parameter Characteristics
 $V_{GSQ} = 1.17\text{ V}$, $V_{DSQ} = 30\text{ V}$, $I_{DQ} = 0.2\text{ A}$
 Pulsed Measurement, Heat-Sink Installed, $Z_0 = 50\ \Omega$

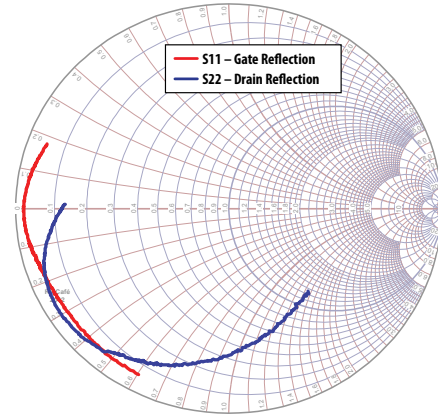


Figure 12: Gain Chart

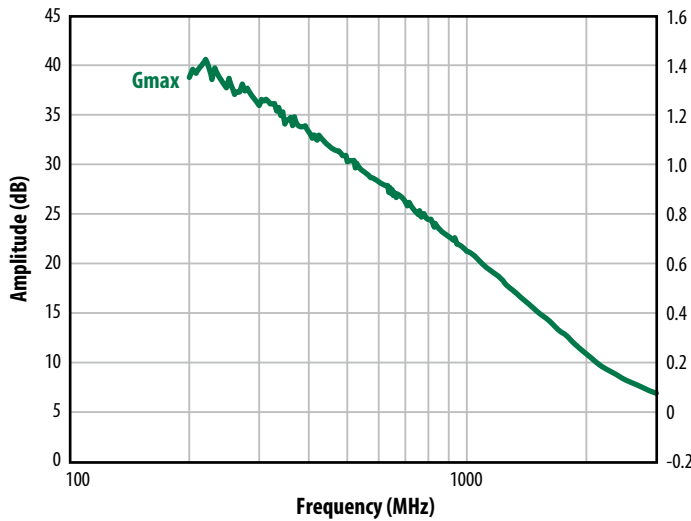


Figure 13: Device Reflection

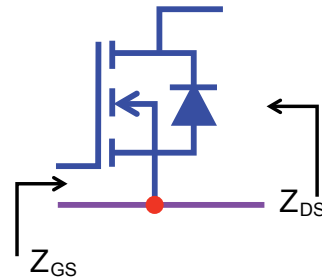
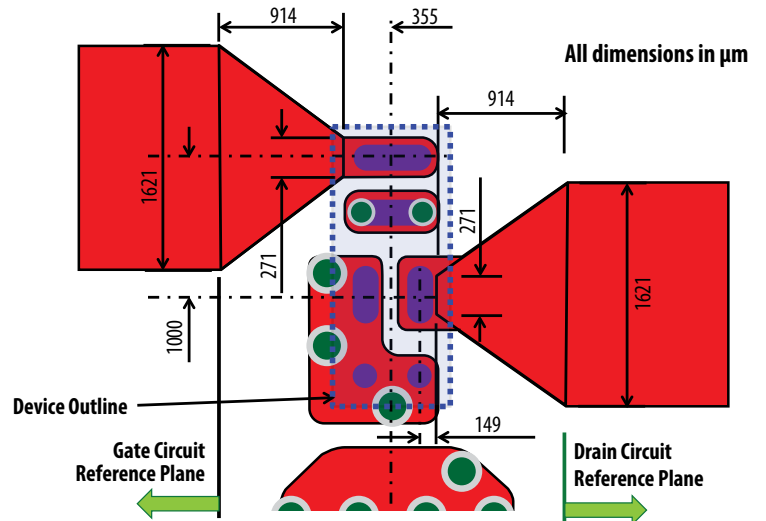


Figure 14: Taper and Reference Plane details – Device Connection

Micro-Strip design: 2-layer
 ½ oz (17.5 μm) thick copper
 30 mil thick R04350 substrate



Frequency [MHz]	Gate (Z_{GS}) [Ω]	Drain (Z_{DS}) [Ω]
200	3.09 - j29.97	63.13 - j71.32
500	2.20 - j11.92	15.96 - j46.65
1000	1.14 - j4.46	3.35 - j23.47
1200	0.95 - j2.76	1.91 - j18.52
1500	0.87 - j0.55	1.66 - j12.66
2000	1.09 + j2.61	2.28 - j6.12
2400	1.44 + j4.87	4.35 - j2.80
3000	2.36 + j8.79	6.41 + j0.69

S-Parameter Table - Download S-parameter files at www.epc-co.com

Figure 15: Typical Transient Thermal Response Curves

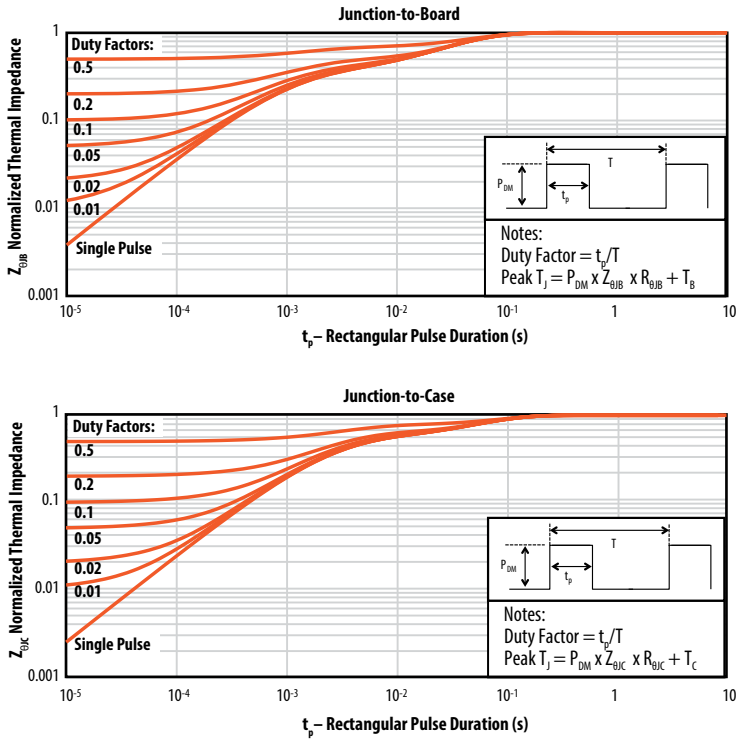
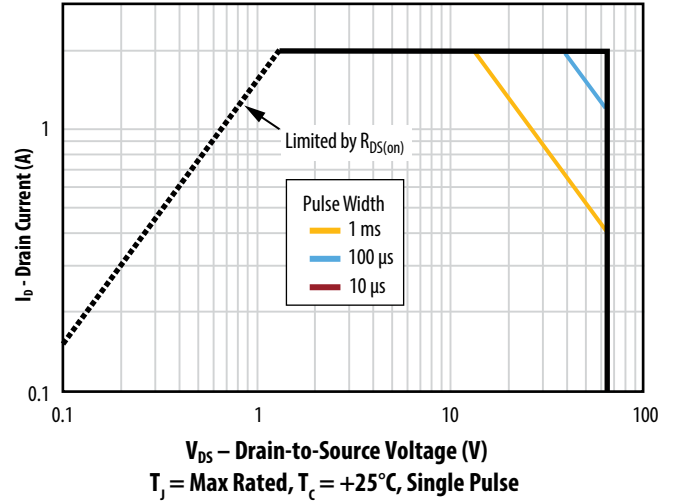
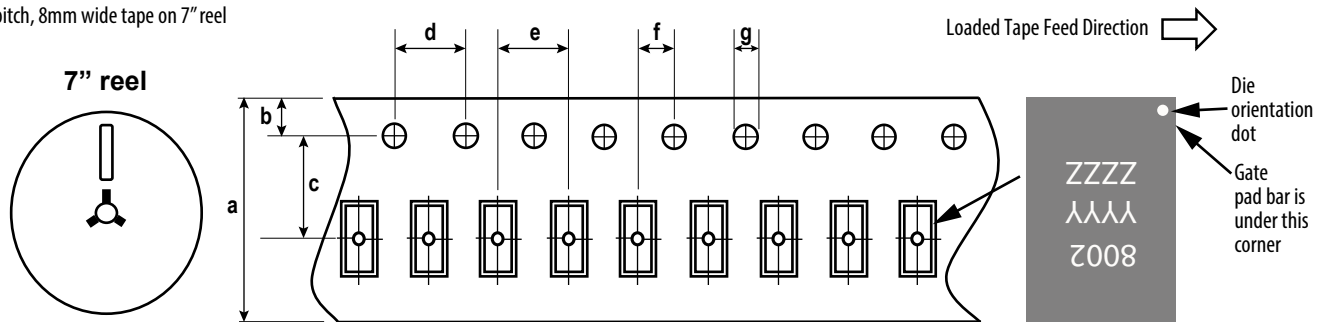


Figure 16: Safe Operating Area



TAPE AND REEL CONFIGURATION

4mm pitch, 8mm wide tape on 7" reel

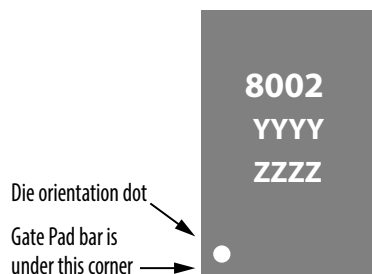


Dimension (mm)	EPC8002 (note 1)		
	target	min	max
a	8.00	7.90	8.30
b	1.75	1.65	1.85
c (see note)	3.50	3.45	3.55
d	4.00	3.90	4.10
e	4.00	3.90	4.10
f (see note)	2.00	1.95	2.05
g	1.5	1.5	1.6

Die is placed into pocket solder bar side down (face side down)

Note 1: MSL 1 (moisture sensitivity level 1) classified according to IPC/JEDEC industry standard.
 Note 2: Pocket position is relative to the sprocket hole measured as true position of the pocket, not the pocket hole.

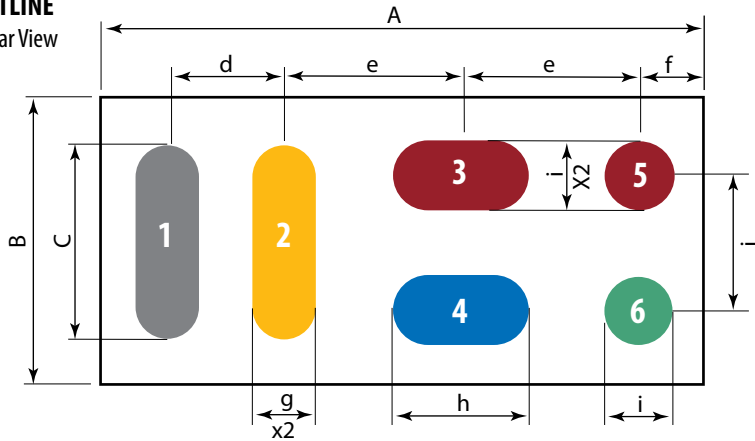
DIE MARKINGS



Part Number	Laser Markings		
	Part # Marking Line 1	Lot_Date Code Marking line 2	Lot_Date Code Marking Line 3
EPC8002	8002	YYYY	ZZZZ

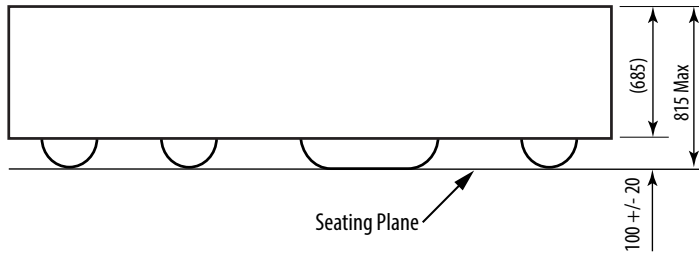
DIE OUTLINE

Solder Bar View



Dim	Micrometers		
	Min	Nominal	Max
A	2020	2050	2080
B	820	850	880
C	555	580	605
d	400	400	400
e	600	600	600
f	200	225	250
g	175	200	225
h	425	450	475
i	175	200	225
j	400	400	400

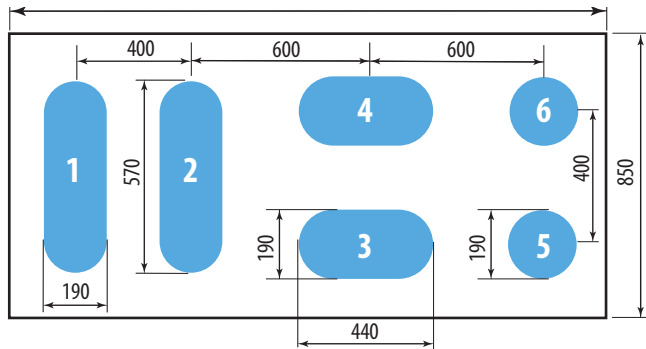
Side View



- Pad no. 1 is Gate
- Pad no. 2 is Source Return for Gate Driver
- Pad no. 3 and 5 are Source
- Pad no. 4 is Drain
- Pad no. 6 is Substrate*

*Substrate pin should be connected to Source

RECOMMENDED LAND PATTERN (measurements in μm)

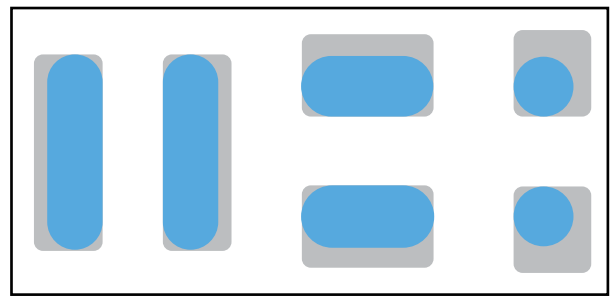
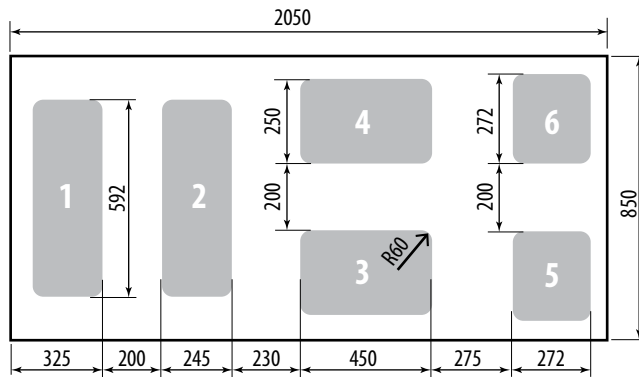


The land pattern is solder mask defined.

- Pad no. 1 is Gate
- Pad no. 2 is Source Return for Gate Driver
- Pad no. 3 and 5 are Source
- Pad no. 4 is Drain
- Pad no. 6 is Substrate*

*Substrate pin should be connected to Source

RECOMMENDED STENCIL DRAWING (measurements in μm)



Recommended stencil should be 4 mil (100 μm) thick, must be laser cut, openings per drawing. Intended for use with SAC305 Type 4 solder, reference 88.5% metals content.

Additional assembly resources available at: <https://epc-co.com/epc/design-support>

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